

Notice of References Cited	Application/Control No. 09/743,925	Applicant(s)/Patent Under Reexamination FOKINA ET AL.	
	Examiner Daniel J. Jenkins	Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,063,907	12-1977	Lee et al.	51/295
	C	US-5,889,219	03-1999	Moriguchi et al.	75/236
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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